

Trace Moisture Contamination in Ultra-High Purity Phosphine: Techniques for Measurement and Control

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Introduction

- Gas purity is critical to the production of III-V compound semiconductor devices
- Trace O from impurities such as H₂O, are incorporated into epitaxial layers during MOCVD processes
 - cause lattice defects and undesirable oxide formation
 - decrease luminescence of optoelectronic components
- Objectives:
 - Investigate methods for measurement of trace H₂O impurity in PH₃
 - Demonstrate moisture control through point-of-use purification



Measurement Techniques

- **Requirements of Trace Analysis Instrumentation**
 - Sensitivity and selectivity for H₂O in PH₃ at ppb levels
 - Rapid and accurate response
 - Rugged and capable of withstanding reactive gas
 - Long term stability
 - Ease of use and applicability to on-line monitoring
- **Techniques Investigated**
 - Chilled mirror hygrometry
 - Cavity ring-down spectroscopy
 - FTIR spectroscopy

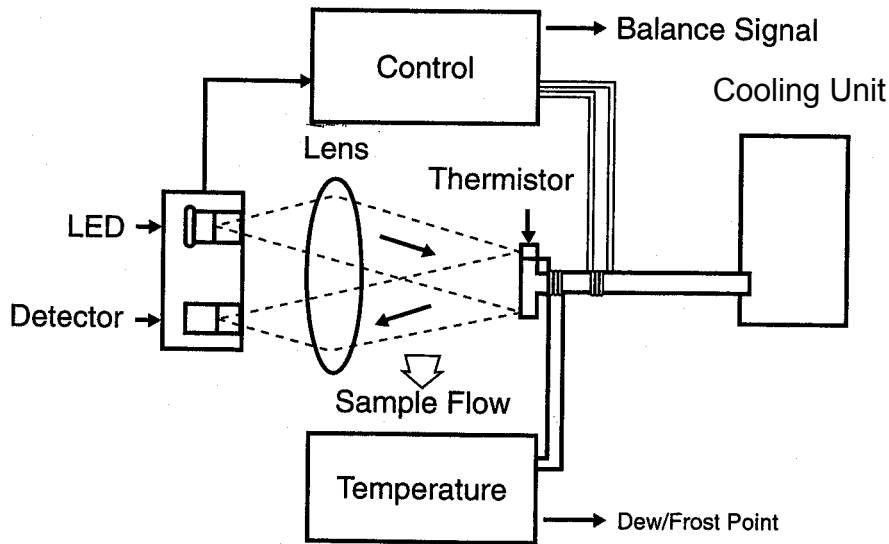


Chilled Mirror Hygrometry

- Frost point is defined as the temperature to which a volume of gas must be cooled such that it becomes saturated with respect to ice.
- Exponential relationship between frost point and H₂O concentration is well documented in N₂
- Fundamental measure of H₂O concentration
- Capable of long-term accuracy and stability
- Calibration required in PH₃
- Condensation temperature of the PH₃ matrix gas limits the ultimate sensitivity of the technique

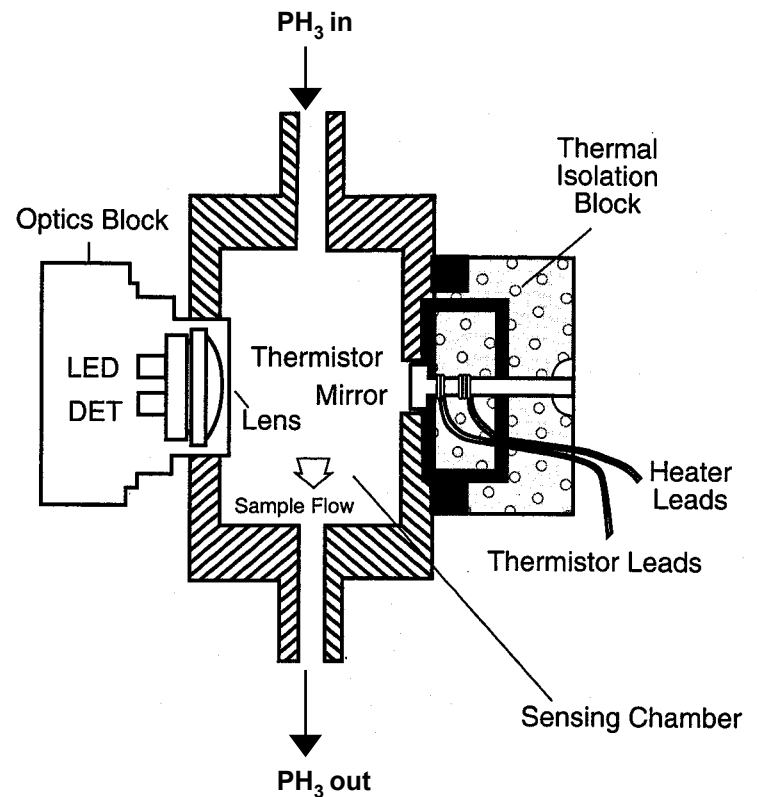


Chilled Mirror Hygrometer



The mirror temperature is cooled until a frost layer is established. The mirror temperature is adjusted to maintain a constant condensation layer on the mirror. The layer is monitored optically and displayed as a balance voltage

Cryogenic Sensing Chamber and Mirror Assembly

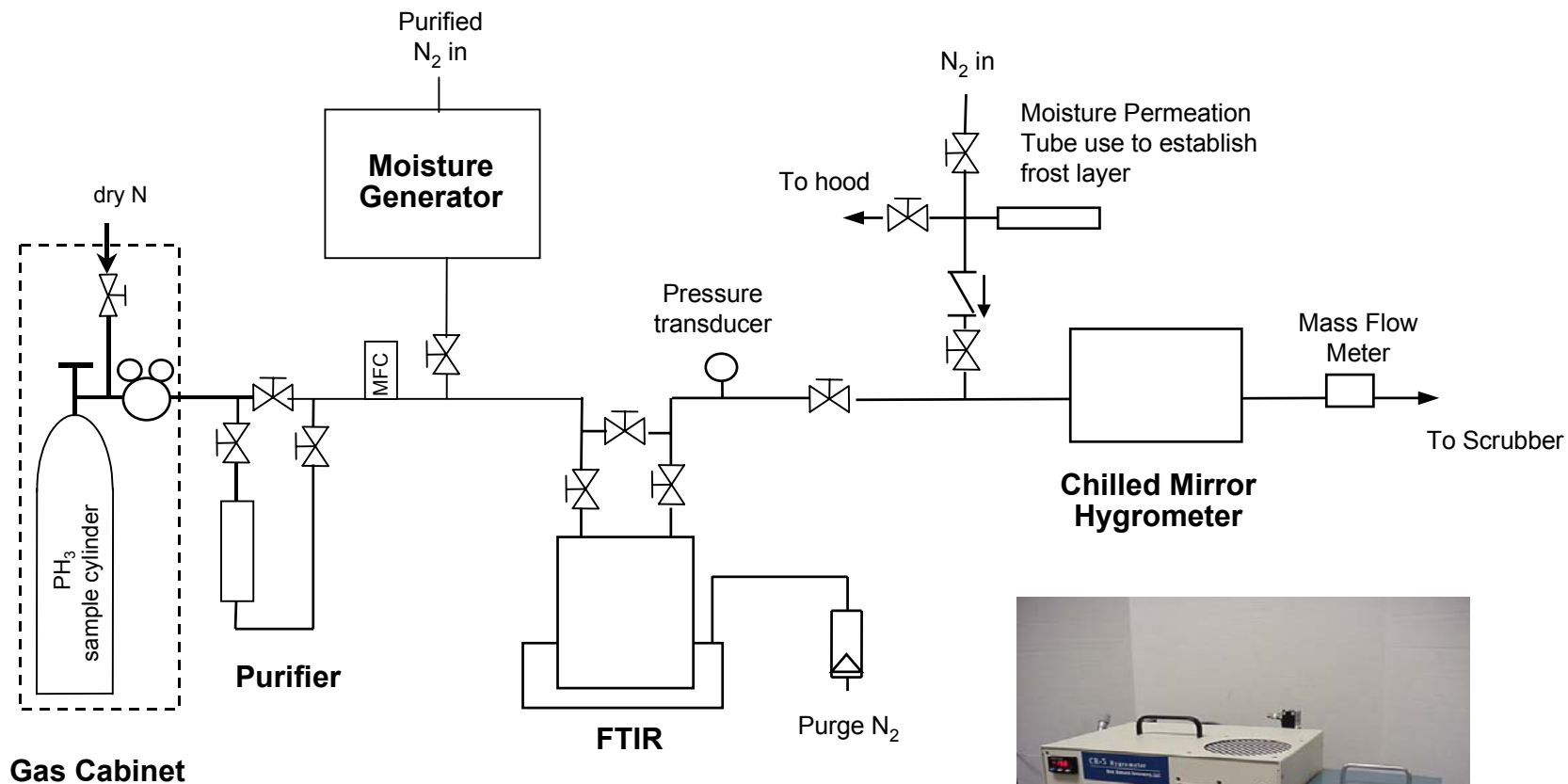


Buck Research CR-3 Chilled Mirror Hygrometer

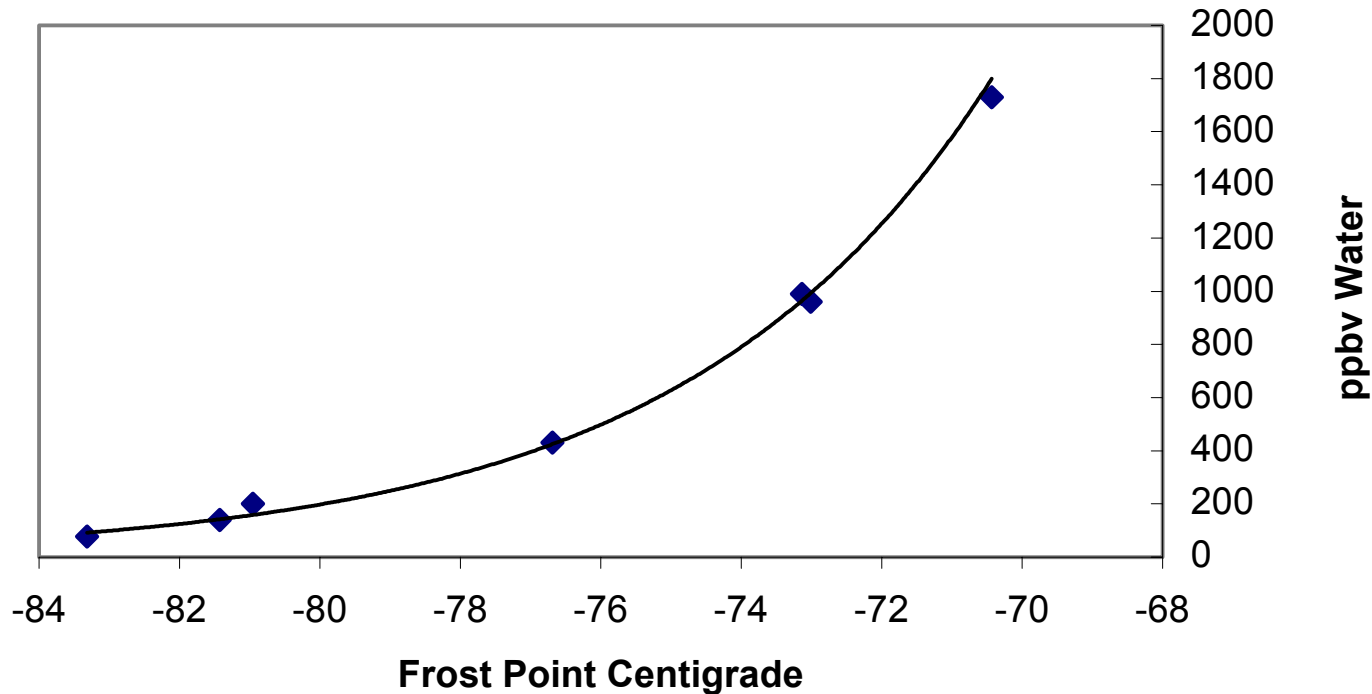


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Setup for Evaluation of Chilled Mirror Hygrometer



Calibration Curve for Moisture in Phosphine using the Chilled Mirror Hygrometer

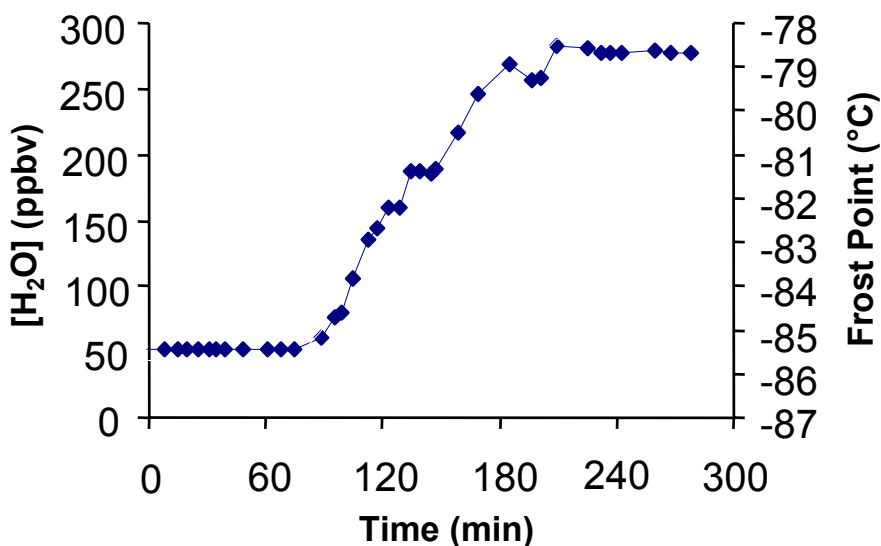


- Calibration points from 77 - 1730 ppbv moisture in PH_3 (1 slpm, 14.7 psia)
- Percentage of N_2 in PH_3 kept below 1% for all calibration points
- System equilibrated for ~4 hours at each moisture concentration



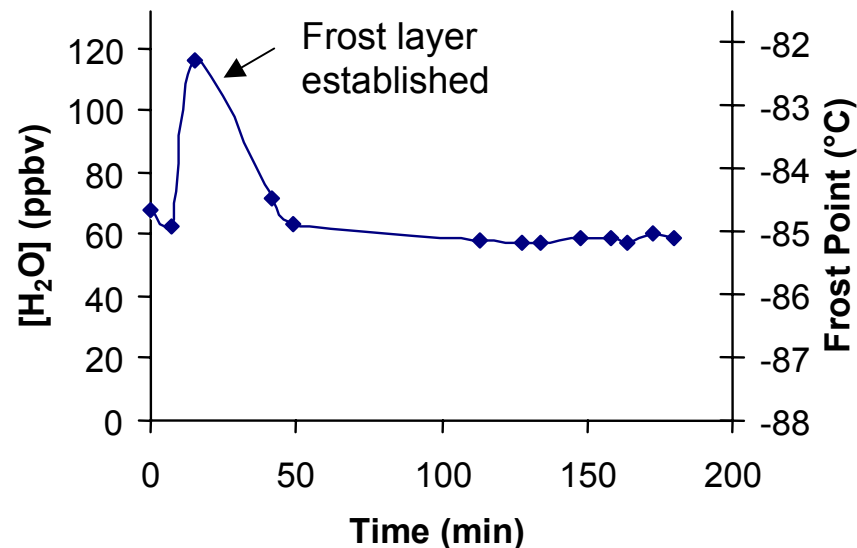
Moisture Detection in Phosphine Cylinder Sources Using Chilled Mirror Hygrometer

278 ppb H₂O in PH₃



- PH₃ from cylinder source, (N5.7 purity) at 1 slpm
- Long equilibration time

59 ppb H₂O in PH₃



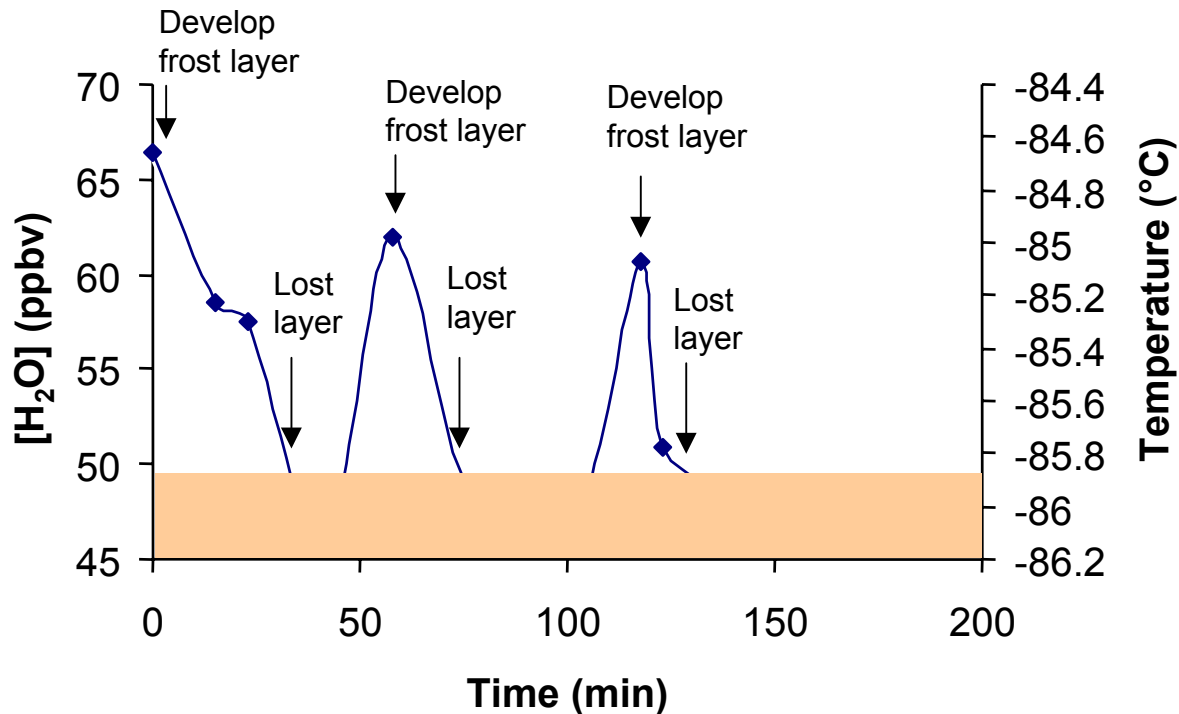
- PH₃ from cylinder source, (Ultima 6N purity) at 1 slpm
- Once established, frost layer maintained during analysis



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Detection Limit



- Mirror could not be cooled below minimum mirror set-point of -86°C due to potential condensation of liquid PH₃
- H₂O concentration in PH₃ less than detection limit

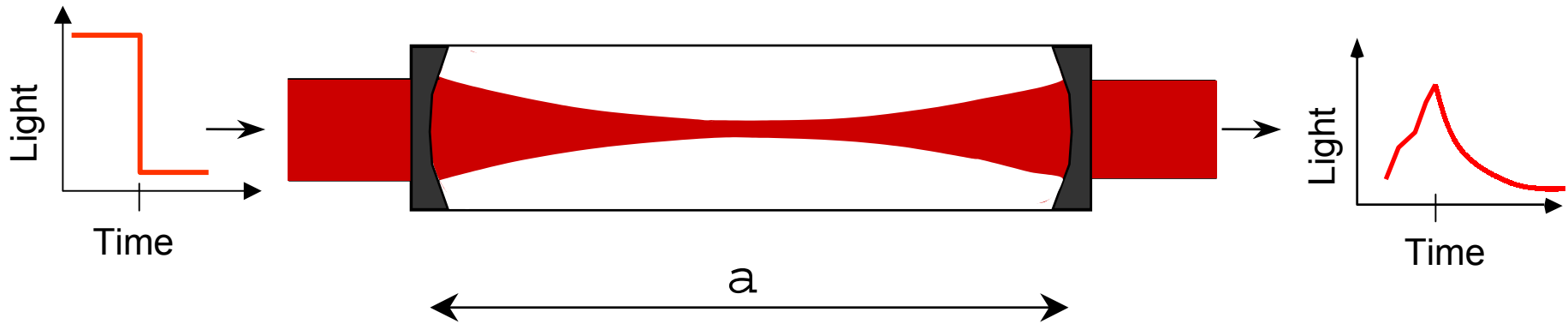


Observations with Chilled Mirror Hygrometer

- Detection of H_2O in PH_3 possible down to ~55 ppb
- Reestablishing frost layer is time consuming and requires user intervention
- Mirror contamination occurs over time and results in noisy readings
- Regular cleaning
- Long equilibration time



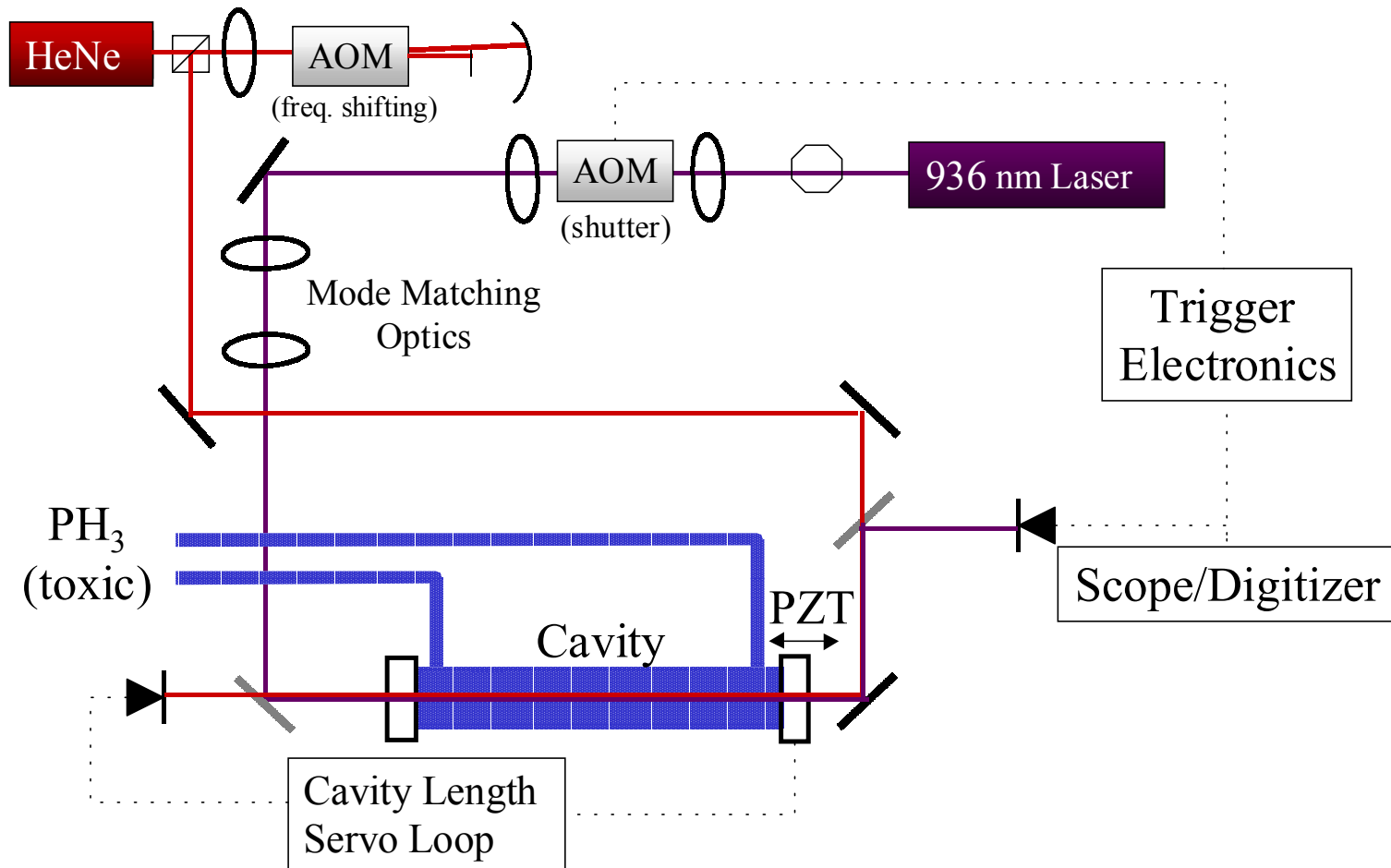
Principle of Cavity Ring-Down Spectroscopy



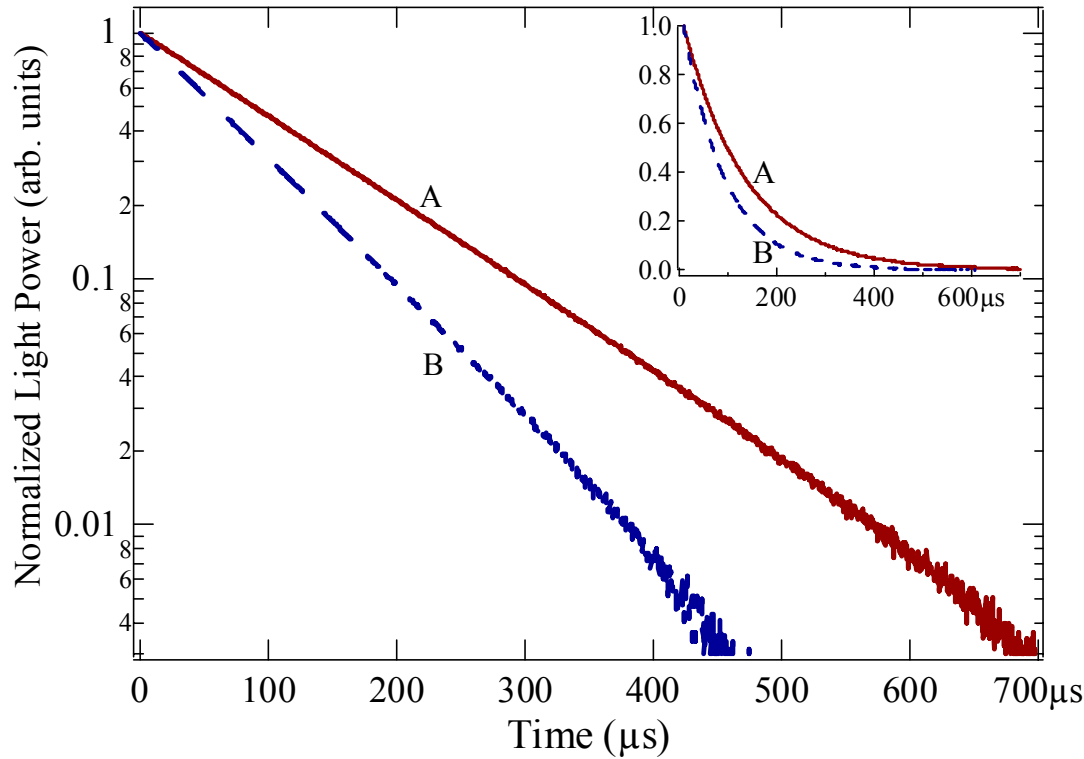
- Light is injected at a frequency, matched to an absorption frequency of the impurity being measured
- When the cavity and the input frequency are in resonance, the cavity fills with light
- The output light increases, triggering the shutter on the input light
- The light in the cavity recirculates and decays exponentially



Schematic of CRDS System at NIST



Ring-down Signals



$$\tau(\nu) = \frac{a}{c} \cdot \frac{1}{L_{tot}(\nu)}$$

t = ring-down time

a = cavity length

c = speed of light
(in cavity medium)

L_{tot} = total loss per pass

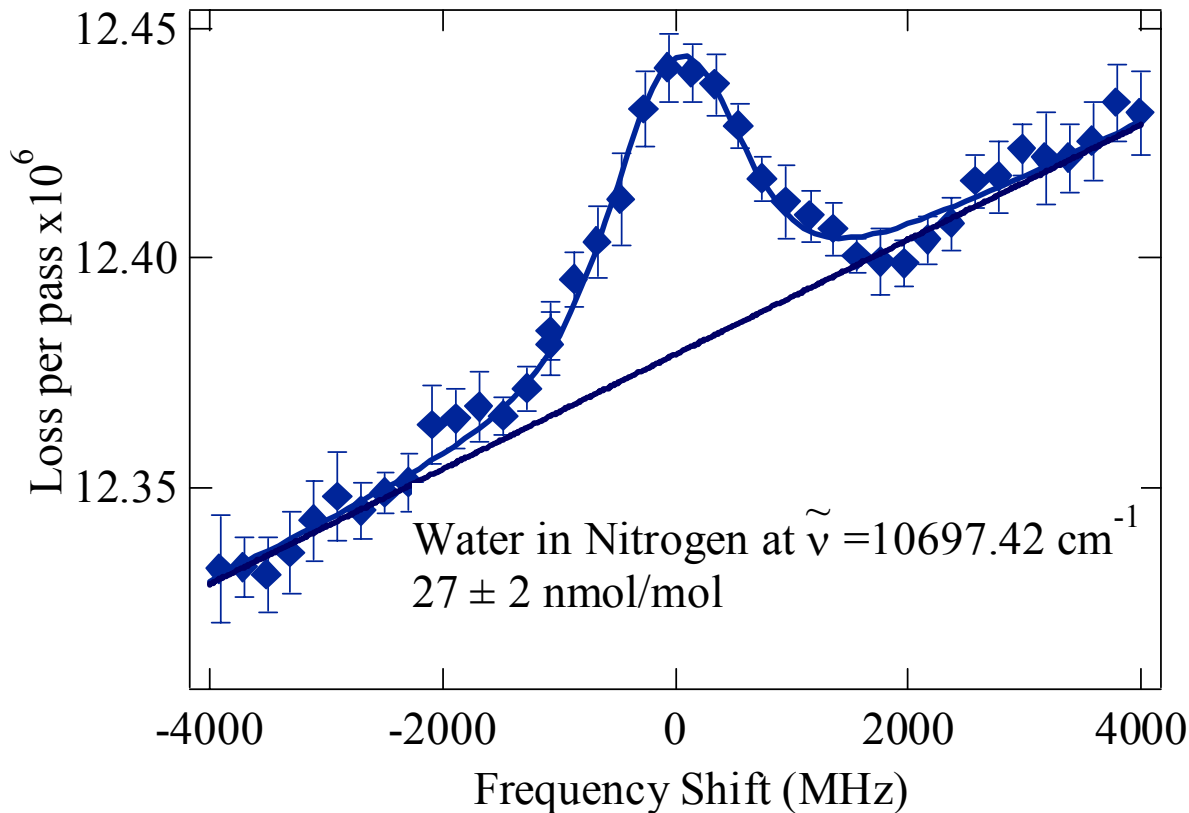
Ring-down time depends on

- base losses (frequency independent at this scale)
- absorption losses (frequency dependent)



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CRDS Results: Dry cavity—nitrogen



$$\tau(\nu) = \frac{a}{c} \cdot \frac{1}{L_{tot}(\nu)}$$

Model absorption lines as Voigt profiles on a linear baseline.

Number density is then:

$$n = \frac{Area}{a \cdot S}$$

a = cavity length

S = absorption line strength

Water concentration is directly proportional to the peak area.

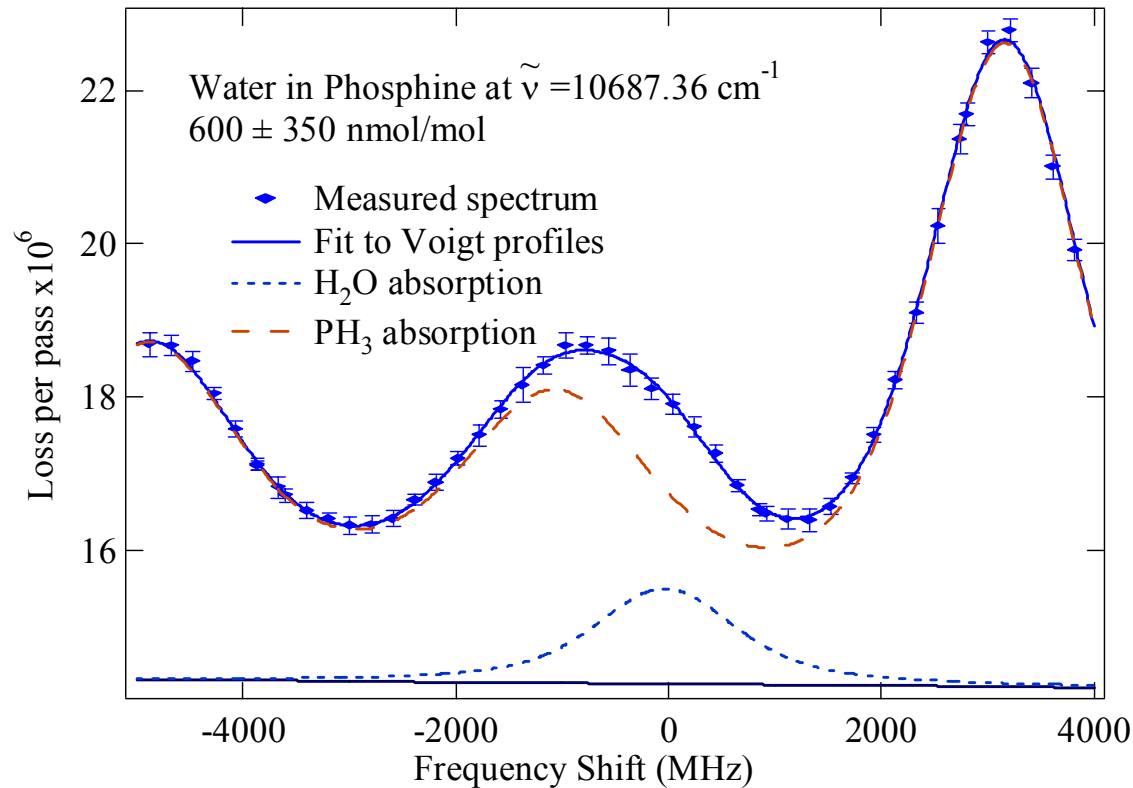
$27 \pm 2 \text{ nmol/mol}$ water in nitrogen (27 ppb)



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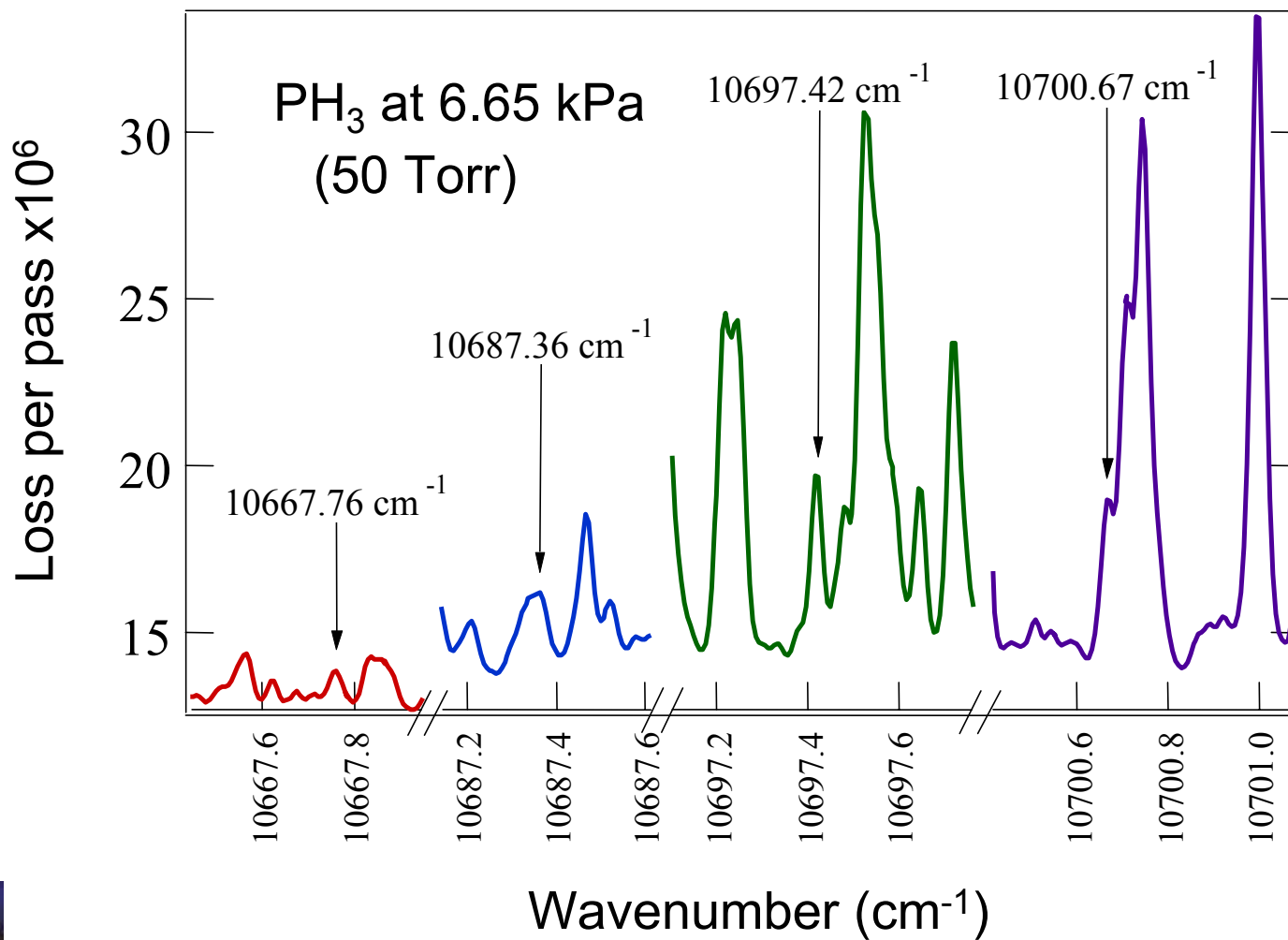
PH₃ Interference at 10687.36 cm⁻¹



- For low concentrations of H₂O, there is too much interference from unmapped PH₃ absorption to accurately deconvolve the absorption lines
- Detection limit in N₂ at this absorption line < 15 nmol/mol (15 ppb)

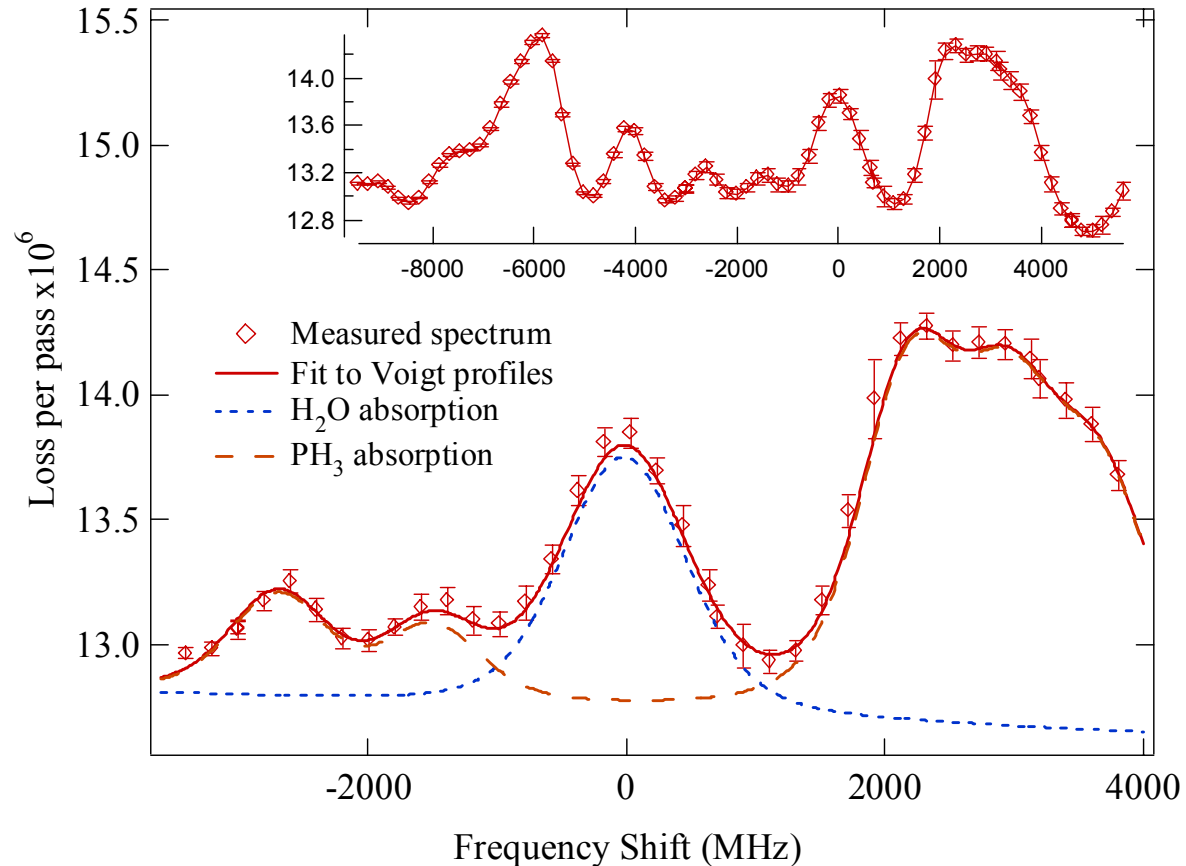


Survey of Strong H₂O lines near 935 nm



CRDS Spectrum: 6.65 kPa PH₃ at 10667.76 cm⁻¹

- H₂O mole fraction = 590 ± 160 nmol/mol
- Pressure-broadening coefficient = 28 ± 7 MHz/kPa
- Background also changes with pressure



Estimated detection limit = 50 nmol/mol (50 ppb)



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CRDS Summary

- **Potential of CRDS for trace H₂O detection in PH₃ demonstrated by NIST researchers**
- **Challenge to find a moisture line in 935 nm region where PH₃ absorptions are minimal**
- **Estimate 50 ppb detection limit using line at 937.40350 nm (10667.76 cm⁻¹)**
- **Future**
 - **Investigate other spectral ranges to lower detection limits**



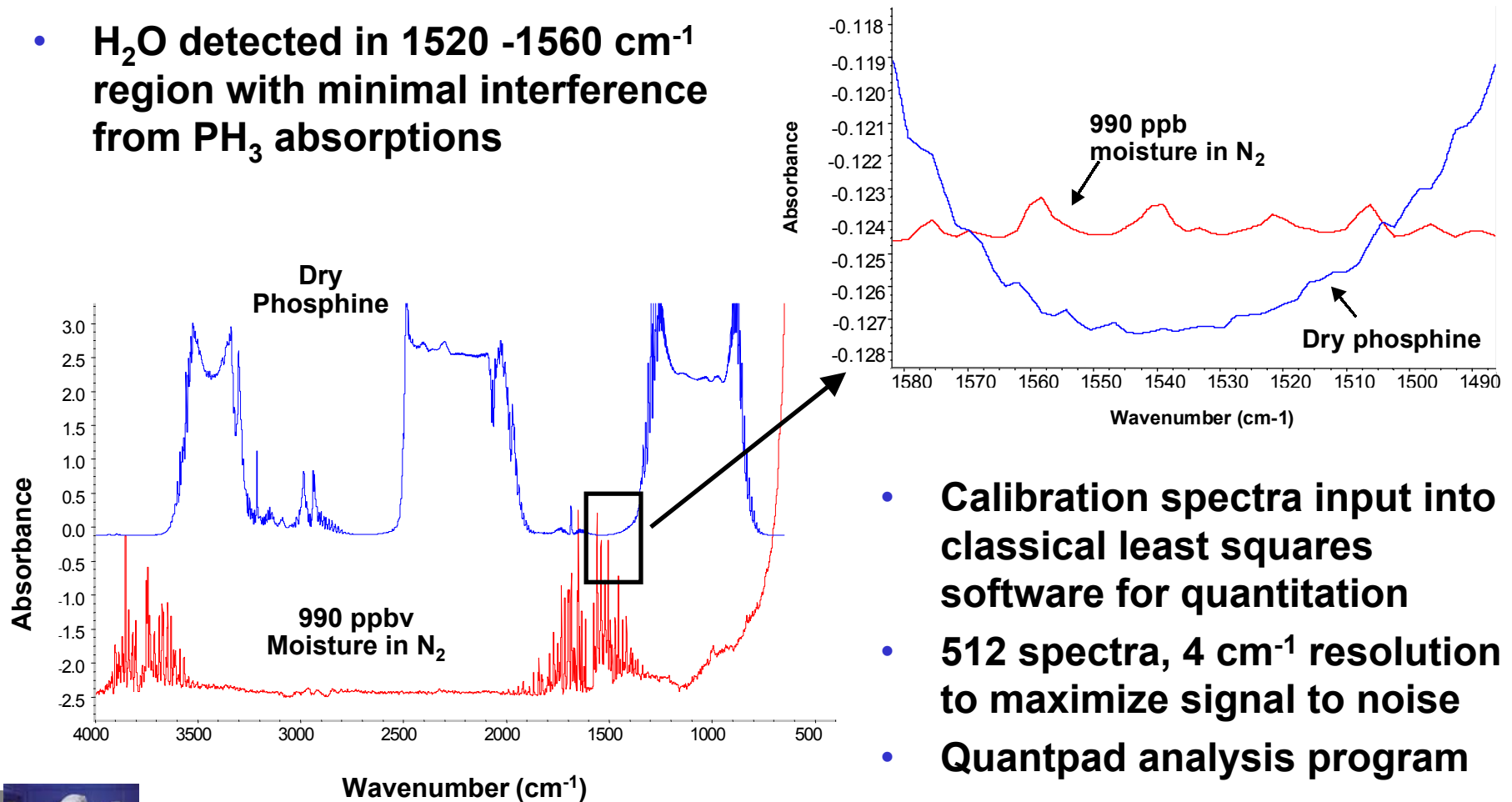
FTIR Spectroscopy

- Based on absorption of IR radiation by moisture impurity in a flowing gas stream within a gas cell
- Non-destructive technique
- Gas wetted parts can be selected for compatibility with phosphine
- Demonstrated sensitivity with long path-length cell
- Requires optimization of instrument design and measurement conditions



Infrared Spectrum of Dry PH₃ and Moisture in N₂

- H₂O detected in 1520 -1560 cm⁻¹ region with minimal interference from PH₃ absorptions

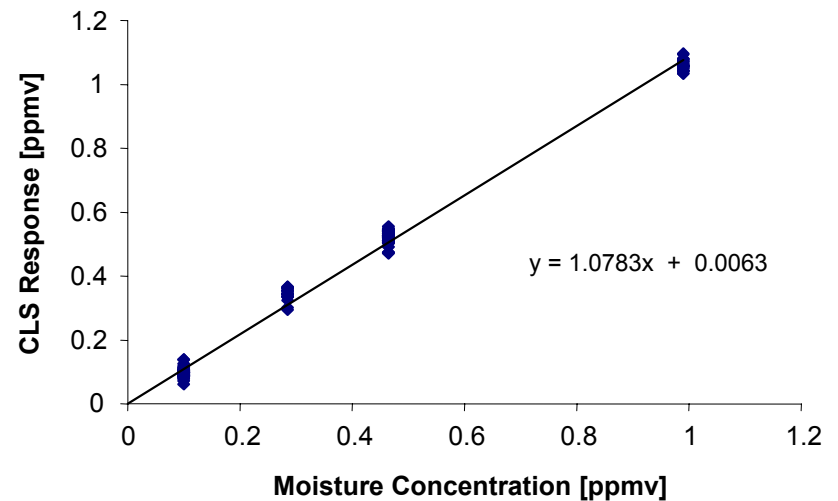


- Calibration spectra input into classical least squares software for quantitation
- 512 spectra, 4 cm⁻¹ resolution to maximize signal to noise
- Quantpad analysis program



FTIR Response

- IR absorption of moisture follows Beer's law ($\text{Log } I/I_0 = -abc$)
- Linear response for H₂O standards diluted in dry PH₃ matrix
- LOD_{REG}: 33 ppbv
- Dry N₂ bench purge required for long term stability
- Air must be excluded from sampling system to prevent PH₃ decomposition products affecting results

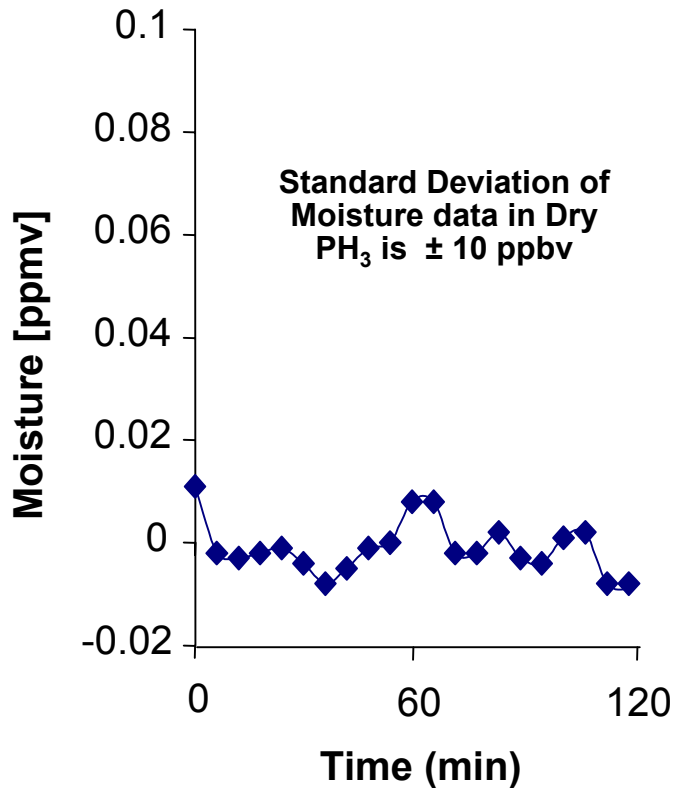


LOD_{REG} based on ordinary least squares method (SEMI C10-0698)

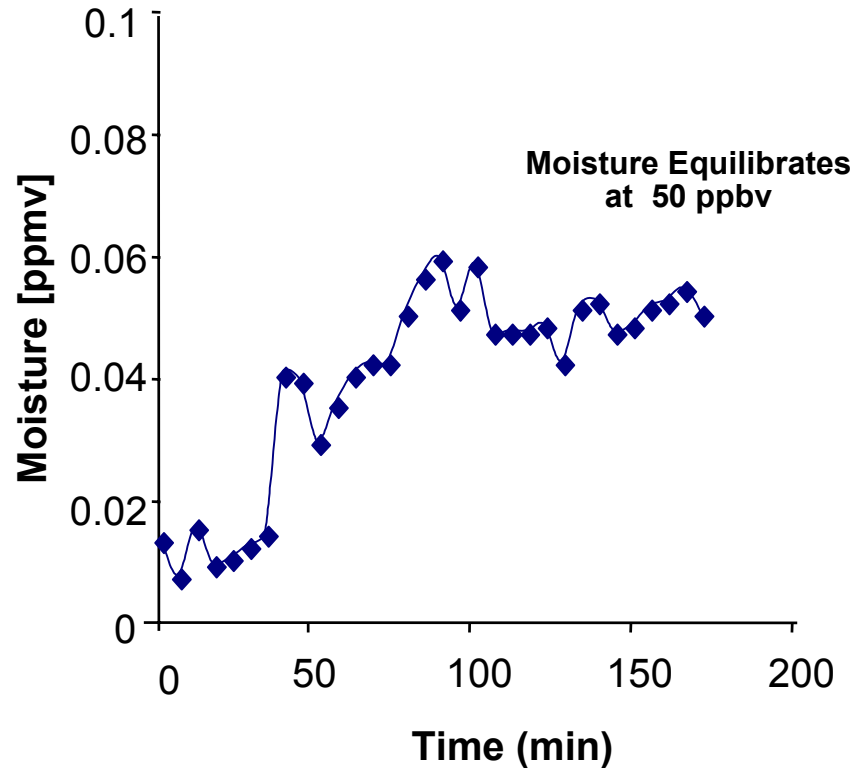


FTIR Detection of Moisture in PH₃

Dry PH₃



PH₃ Ultima 6N Grade from Cylinder Source



FTIR Observations

- FTIR currently method of choice for quantification of trace H₂O in PH₃
- Careful selection of H₂O bands required to optimize sensitivity
- Detection to ~30 ppb possible with low resolution instrument, an MCT detector and a 10 m pathlength cell
- Improved sensitivity (10-20 ppb) likely with dedicated FTIR analyzers optimized for on-line gas measurements



Moisture Control

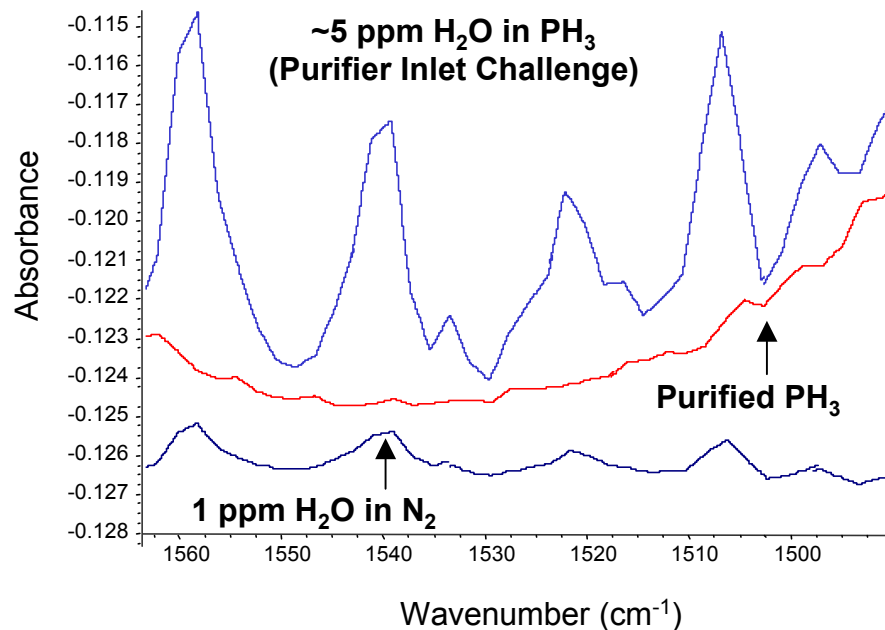
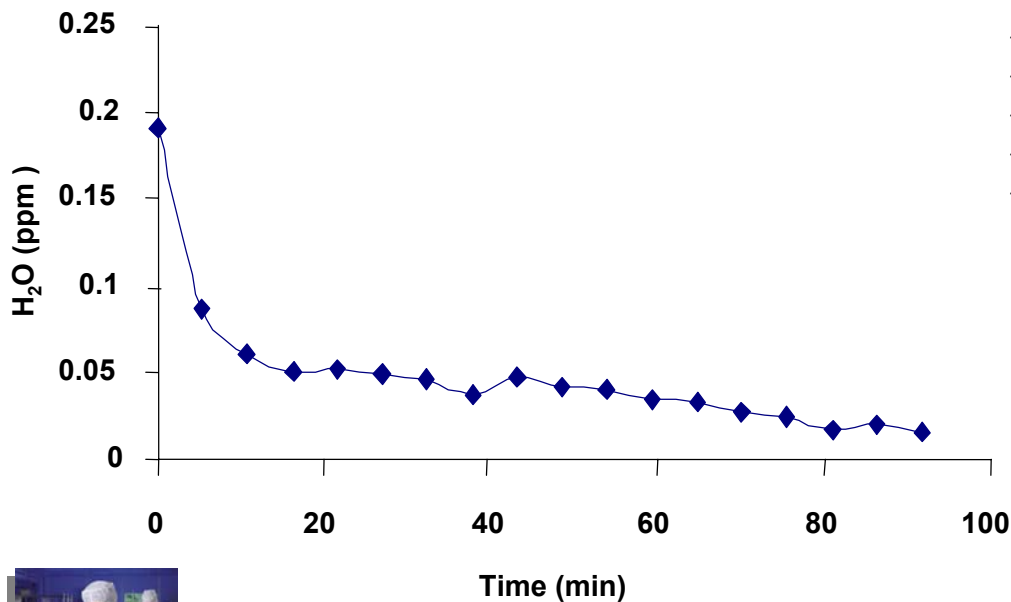
- Dry down of delivery systems exposed to atmosphere difficult due to adsorptive properties of moisture
- Gas phase moisture concentrations may vary over cylinder life, due to enrichment of water in the liquid phase
- Point-of-use purification provides a solution for consistent gas purity
- Efficiency of purifier materials evaluated using FTIR



Removal of H₂O in PH₃ by Point of Use Purifier

Removal of 5 ppm H₂O in PH₃ by Nanochem PHX Purifier at 0.4 slpm

*<100 ppb H₂O reached in 10 min
H₂O level less than FTIR detection limit after 80 min*



IR spectra showing features of 5 ppm inlet H₂O challenge and absence of features in purified PH₃



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Summary and Outlook

- Current techniques allow H₂O detection at tens of ppbs
- Performance of some III-V devices may be effected by H₂O at much lower levels than can be measured analytically
- Point-of-use purification important for consistent gas purity
- Next generation analyzers should provide single digit and sub-ppb level sensitivity
- Laser based systems have greatest potential of filling sensitivity requirement

